Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/691,166	KOCH ET AL.
Examiner	Art Unit
Quang N. Nguyen	2141

SEARCHED				
Class	Subclass	Date	Examiner	
709	220	3/21/2007	QN	
709	221	3/21/2007	QN	
709	224	3/21/2007	QN	
709	226	3/21/2007	QN	
709	229	3/22/2007	QN	
709	232	3/22/2007	QN	
709	238	3/22/2007	QN	
709	250	3/22/2007	QN	
709	223	10/15/2007	QN	
709	230	10/15/2007	QN	
709	240	10/15/2007	QN	
709	245	10/15/2007	QN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
709	223	10/15/2007	QN	
709	224	10/15/2007	QN	
709	230	10/15/2007	QN	
709/240, 245		10/15/2007	QN	

SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
Inventor Name Search	3/21/2007	QN
East Search (see notes)	3/21/2007	QN
East Search (see notes)	3/22/2007	QN
East Search (see notes)	10/11/2007	QN
IEEE Search (see notes)	10/15/2007	QN
Google Search (see notes)	10/15/2007	QN